

# Signal Conditioning: RTD sub-module

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Ph.D. Electrical Engineering

- Role:
  - HW (signal conditioning) designer
- Relevant Experience:
  - Projects on machine vibration monitoring hardware engineer (2006 2011)
  - TULCOEMPA hardware designer (2011 2015)
  - SPParTAN hardware designer (2019 2022)
  - FOSREM hardware designer (2021 present)

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Ph.D. Electrical Engineering

- Role:
  - HW (signal conditioning) designer
- Relevant Experience:
  - INNOREH software designer (2017 2021)
  - SPParTAN firmware designer (2019 2022)
  - ITER hardware engineer (2021 2022)
  - FOSREM hardware designer (2021 present)





- The RTD module requirements,
- The PoC version specification and scope
- The sub-module design details
- Implementation
- Test results discussion
- Full scale design plans
- Summary



# The RTD sub-module requirements

- The RTD signals group: RTD 1, RTD 2
- Redundant temperature measurement based on PT-103 sensor (x4)
- Sensor current: up to 1 mA excitation, configurable (0 1 mA)
- Accuracy: 1 K; Resolution: 100 mK; Range: 275 300 K
- Radio-Frequency Interference (RFI) Immunity (4-wire sensing)
- GPIO and SPI signals isolation

Signal Name	Peripher al Need	ner	IO Pins Per RFPI	Signal Type	Quantity	I/O	RFPI Response Time	Impedance	Signal Range	Cable Type
Temperature Probe RTD 1, (PT-103)		4	16	Analog	1 per cavity/couple r	Input	<10 µs	100-110 Ω	10-110 mV, 0.1 - 1 mA excitation	Belden 1325A
Temperature Probe RTD 2, (PT-103)		4	16	Analog	1 per cavity/couple r	Input	<10 µs	100-110 Ω	10-110 mV, 0.1 - 1 mA excitation	Belden 1325A



# P.J.L

# The PoC version specification and scope

- One PCB board which supports redundant temperature measurements: RTD 1, RTD 2
- 4 spare measurement inputs connected to ADC
- Sensor current range: 0 to 1 mA
- Input voltage amplification:
  Diffrence Amplifier (30 V/V) \* Programmable Gain Amplifier (1 32 V/V)
- Management Block
- Power Supply Voltage: 12 V
- Management Block Supply Voltage: 3.3 V
- Isolation of SPI signals
- Temporary Connector type: BNC



# The PoC version specification and scope

Management Block:

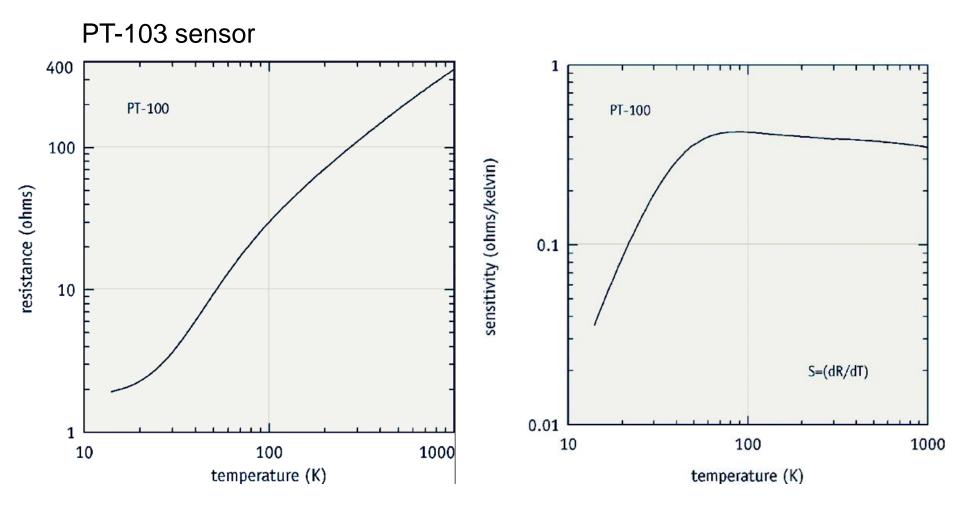
- I<sup>2</sup>C communication with Raspberry PI
- Current measurement
- Temperature and humidity measurements





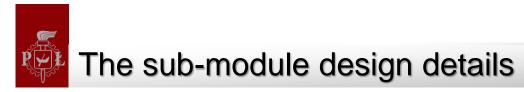




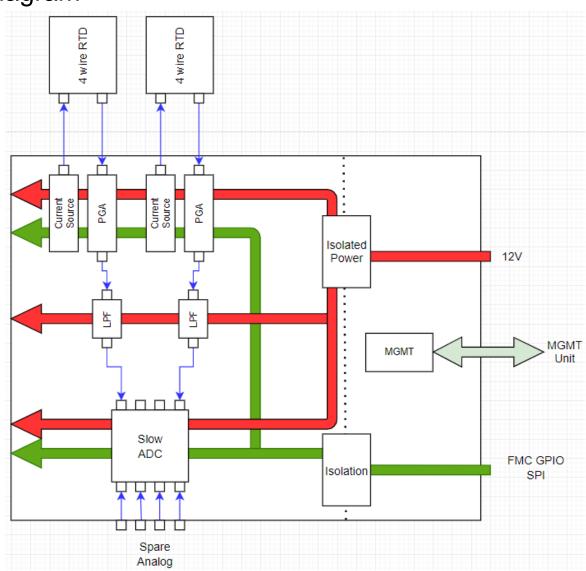




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#### Conceptual diagram

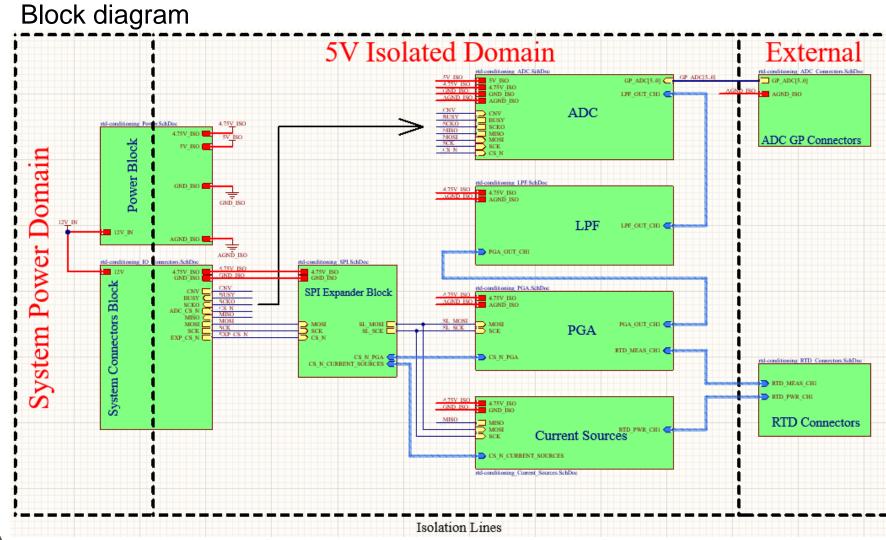




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# The sub-module design details







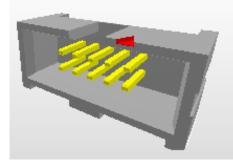
#### **System Connectors Block**

Power Connector (12 V)

MGMT Connector (I<sup>2</sup>C) and sensors

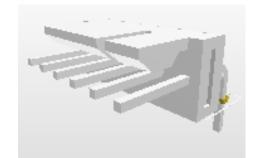
FMC GPIO Connector (SPI)





of GPIO Isolation SPI signals based on MAX22245BAWA+ and and ٠ MAX22246CAWA+ digital isolators (2 channels, 7 ns delay, up to 25 / 200 Mbps, 868  $V_{RMS}$  continous / 5 k $V_{RMS}$  60s / 12.8 k $V_{RMS}$  surge galvanic isolation)



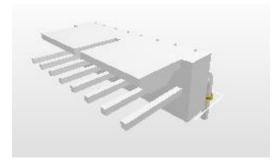






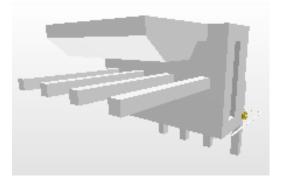
#### **ADC GP Connectors**

• One 8-pin connector (universal) for interconnecting with front panel connectors



#### **RTD Connectors**

• Two 4-pin connectors (universal) for interconnecting with front panel connectors







#### **SPI Expander Block**

 MAX7301 serial-interfaced I/O expander with 28 configurable (logic input or logic output) ports

#### **Current Sources Block**

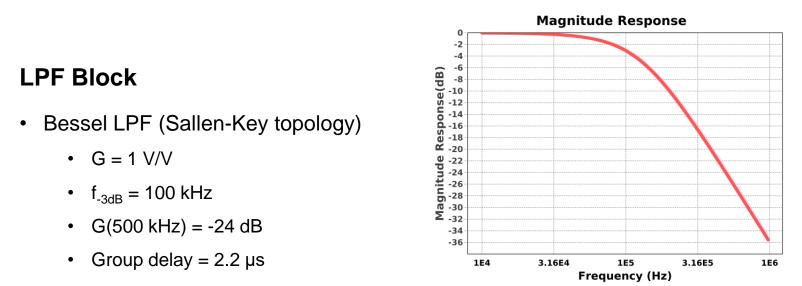
- MCP48FEB24-20E quad, 12-bit resolution buffered voltage output Digital-to-Analog Converters (DAC), with volatile user memory
- MAX6138 bandgap voltage reference (4.096V),
  Operating Current Range: 60 µA to 15 mA, 28 µV<sub>RMS</sub> Output Noise (0.01 to 10 kHz)
- MAX4165 operational amplifier (5 MHz Unity Gain Bandwidth , Input Voltage-Noise Density (26 nV/√Hz), Slew Rate of 2 V/µs)
- P-channel transistor (V<sub>GS</sub> in negative feedback loop of the OPAMP)





#### **PGA Block**

 MCP6S22-I/SN Programmable Gain Amplifiers (PGA) with SPI communication (gain from +1 V/V to +32 V/V) and two output channels



 LMV721M7/NOPB operational amplifier (10 MHz Unity Gain Bandwidth , Input Voltage-Noise Density (8.5 nV/√Hz), Slew Rate of 5 V/µs)





#### ADC Block

- LTC2333CLX-18 18-bit, low noise 8-channel ADC, 800 ksps Throughput, 96.4 dB Single-Conversion SNR
- ADC Power supply
  - TPS65130 split-Rail Converter with dual, positive and negative Outputs (maximum output current: 300 mA)
  - LT3032 dual, low noise, positive and negative low dropout (300 mV) voltage linear regulator with 150 mA maximum output current





#### **Power Block**

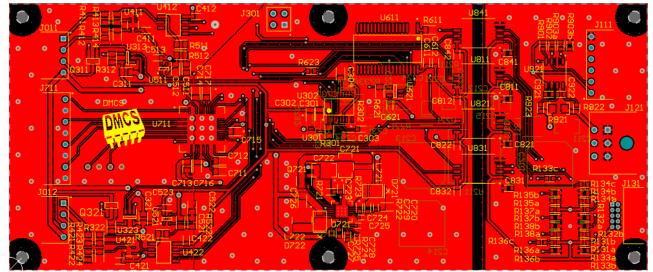
- 12V → 5V SMPC module Traco Power TRS 2-1211 (isolated, 9-18 V input, max. 2 W output power, 80% efficiency, 1.6 kV isolation)
- EN 55032 class A external filter at the input for radiated and conducted emission
- 5V → 4.75V MAX1857EUA47+T Linear Voltage Regulator (up to 5.5 V supply, max. 500 mA load current, 120 mV typical dropout, output voltage accuracy ±1%)

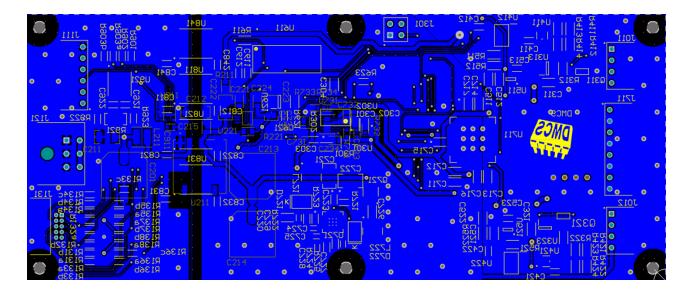




### Implementation

#### 4-layer PCB, dimensions: 144 mm x 60 mm



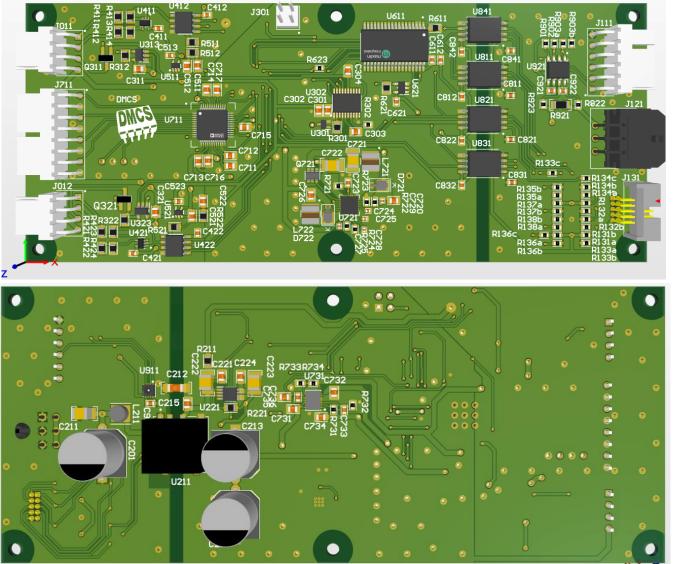






# Implementation

#### 3D model

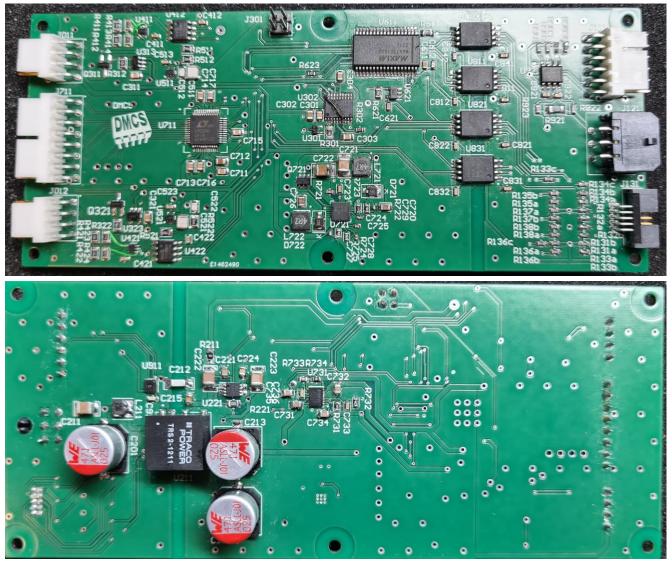








#### Real view





# Test results discussion

- Detection of soldering faults (partially manual soldering)
  - Short circuits
  - Damaged tracks
  - Missing or broken connections
- Operation of the main power supply block and ADC power supply block (correct voltage levels)
- Current source block
- Temperature measurement in both channels (resistances:  $102 \Omega$ ,  $150 \Omega$ )
- I<sup>2</sup>C communication with temperature and supply current sensors

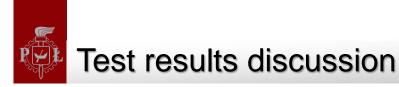




- Detection of soldering faults, e.g. short circuits, damaged tracks, missing or broken connections
  - No errors were detected on the basis of the vision analysis.
- Operation of the main power block (correct voltage levels)
  - The power block works properly
  - Current consumptions are as expected (aprox. 60 mA for 3.3 V voltage domain, and 20 mA for 12 V voltage domain)

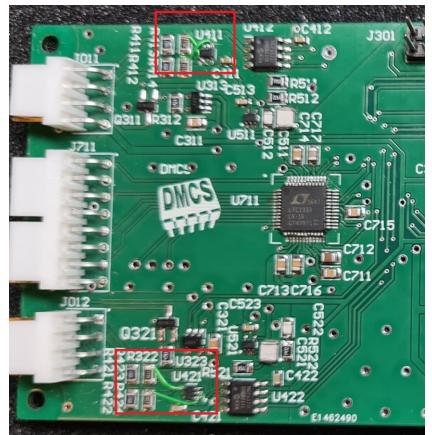






#### Temperature measurement channel

- Error in signal gain was detected in the measurement circuit. The cause was a bad pinout in symbol of the operational amplifier.
- The error was corrected by cutting the paths and soldering the wires correctly.







# Test results discussion

- Operation of the main power supply and ADC power supply blocks (correct voltage levels)
  - Main power supply block works correct
  - ADC power supply block works correct

Test point	Value [V]			
Main power converter output	4.94			
Main LDO output	4.72			
ADC power converter outputs	+10.30/-9.60			
ADC LDO outputs	+8.88/-8.68			

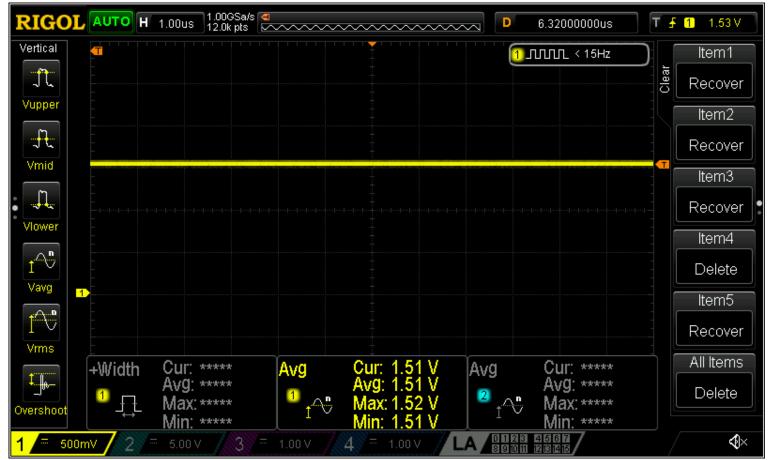
- Current source block
  - Reference voltage and DAC output voltage are correct

Test point	Value [V]
Reference voltage	4.08
DAC output	2.38



#### Temperature measurement channel 1

Measuring circuit works correctly (conditions: sensor resistance = 102 Ω, PGA gain = 1 V/V and sensor current = 0.497 mA). Measured voltage at ADC input is correct (102 Ω x 0.497 mA x 30 V/V = 1.521 V).







#### Temperature measurement channel 1

Measuring circuit works correctly (conditions: sensor resistance = 150 Ω, PGA gain = 1V/V and sensor current = 0.497 mA). Measured voltage at ADC input is correct (150 Ω x 0.497 mA x 30 V/V = 2.237 V).









- I<sup>2</sup>C communication with temperature and supply current sensors
  - As part of the tests, the correctness of I<sup>2</sup>C communication with two sensors was checked:
    - STH31 Connection with the temperature sensor was established and correct temperature was read.
    - INA219 Connection with the sensor was established.





# Full scale design plans

- The presented solution can be adopted in the final design
- Four redundant channels are needed in the final design



- Changes in schematic diagrams (duplication of selected blocks)
- PCB project redesign





- Requirements
  - One redundant measurement channel per cavity => 4 redundant measurement channels per module = 8 measurement channels per module
  - Response time less then 10 µs
- PoC, implementation and verification
  - PCB board supporting one redundant measurement channel and four spare measurement inputs connected to ADC
  - 4-layer PCB
  - Correct operation of the main power block and ADC power supply block
  - Correct operation of the signal conditioning circuit
  - Configurable sensor current
- Full scale design plans
  - Extending the solution to 8 measurement channels





# **Thank You**

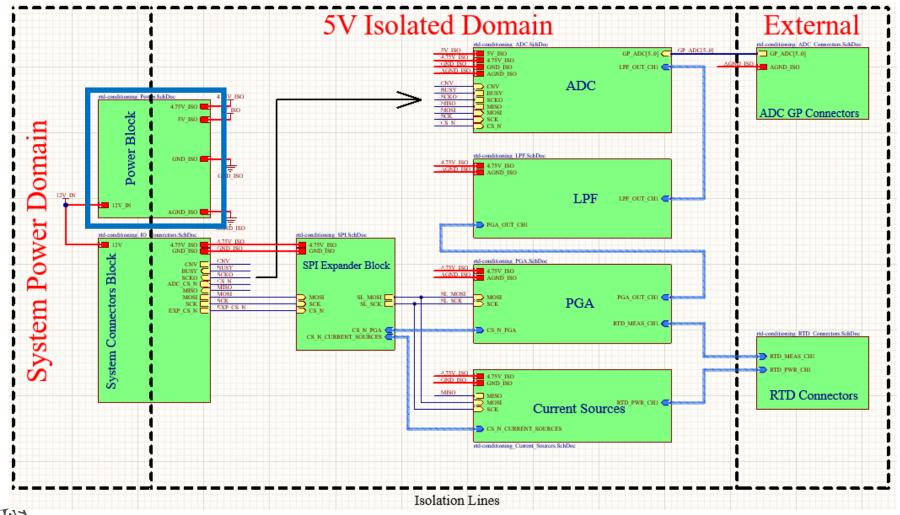


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# The sub-module design details

Power Block



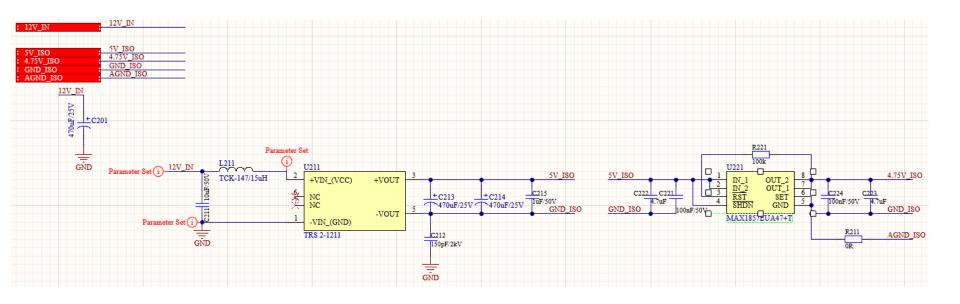


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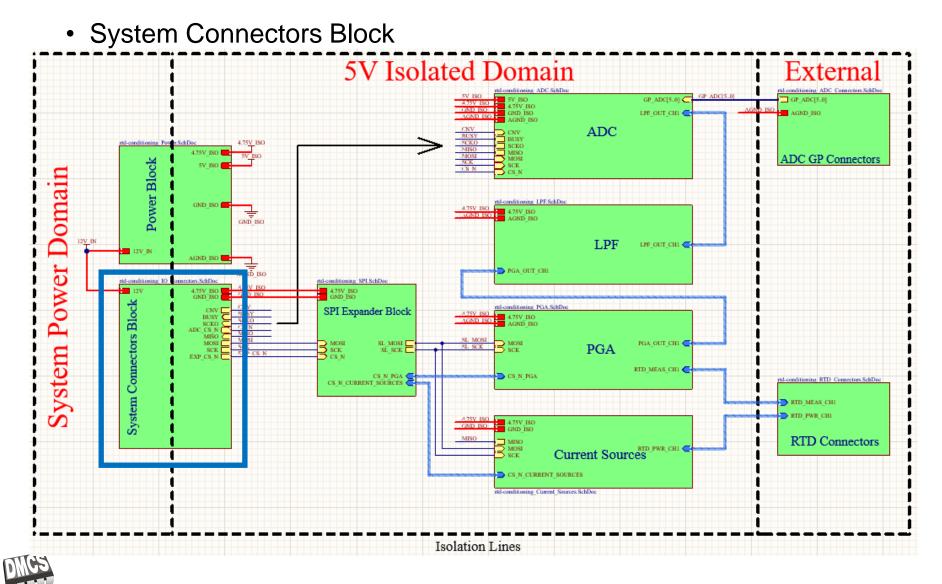
# The sub-module design details

• Power Block



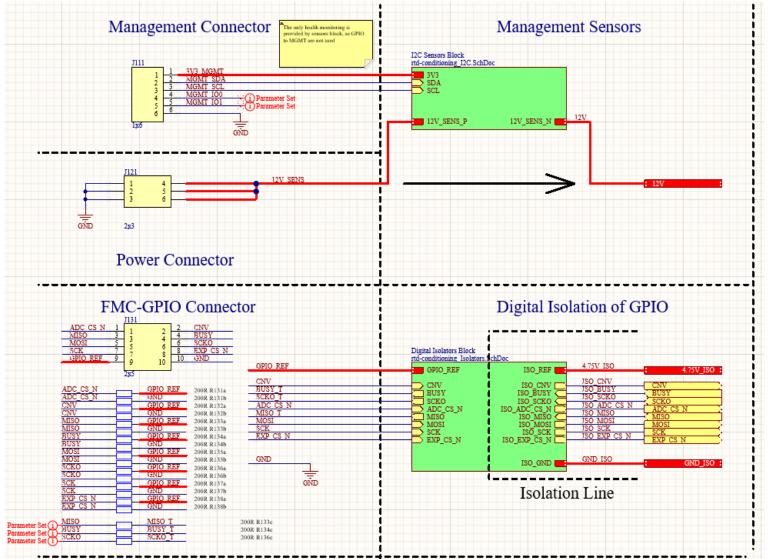






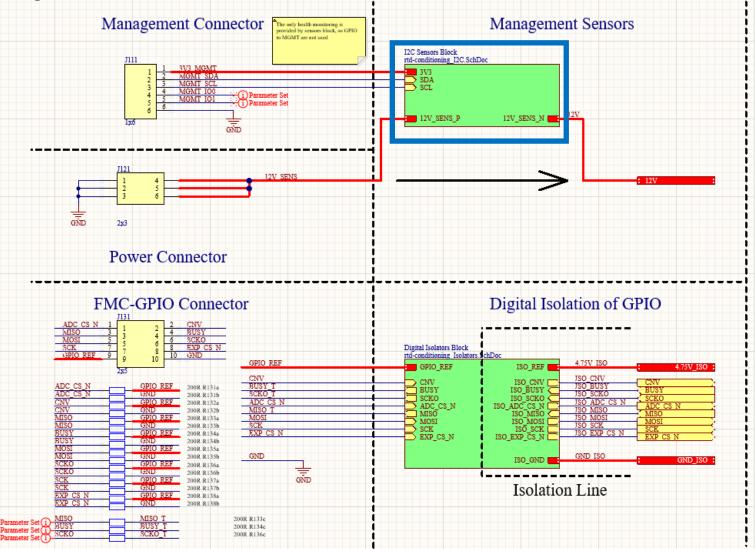


System Connectors Block





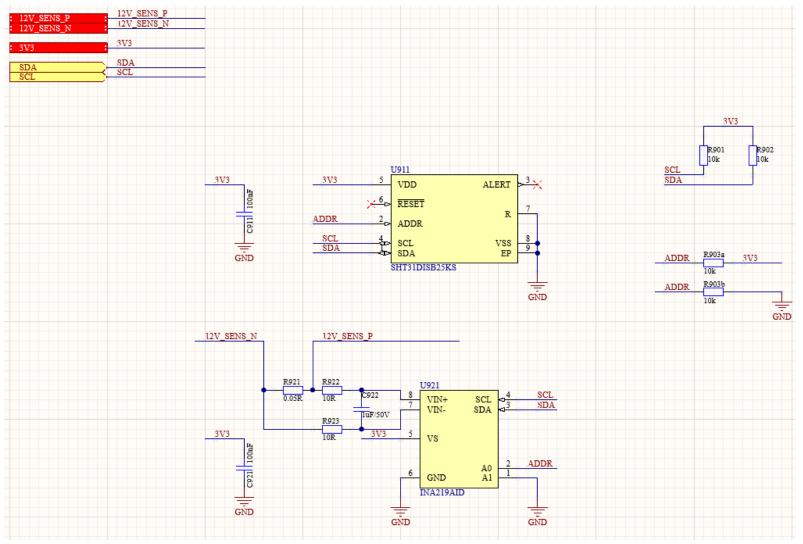
#### **Management Sensors**







#### Management Sensors Schematic Diagram

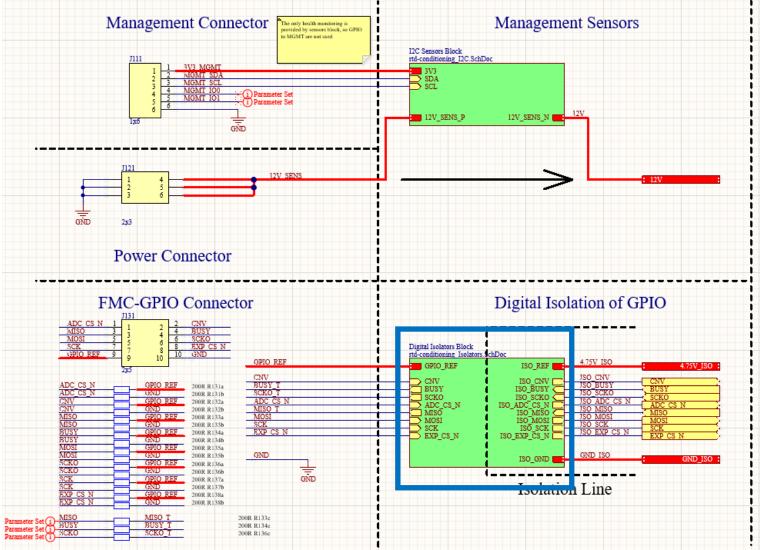


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# The sub-module design details

#### **Digital Isolation of GPIO**

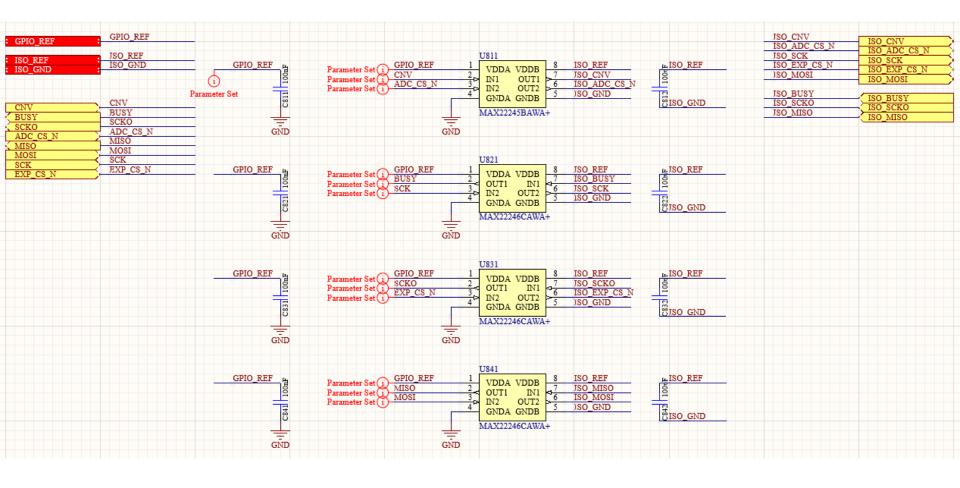








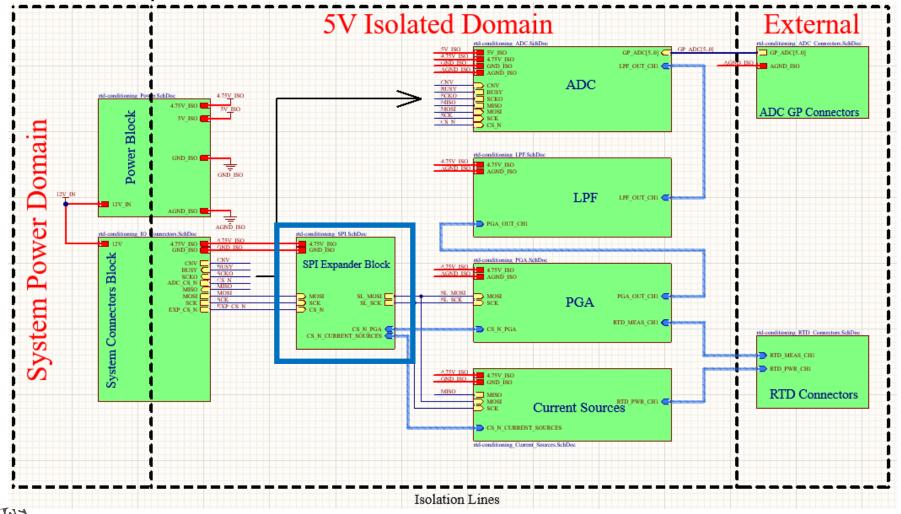
#### Digital Isolation of GPIO Schematic Diagram







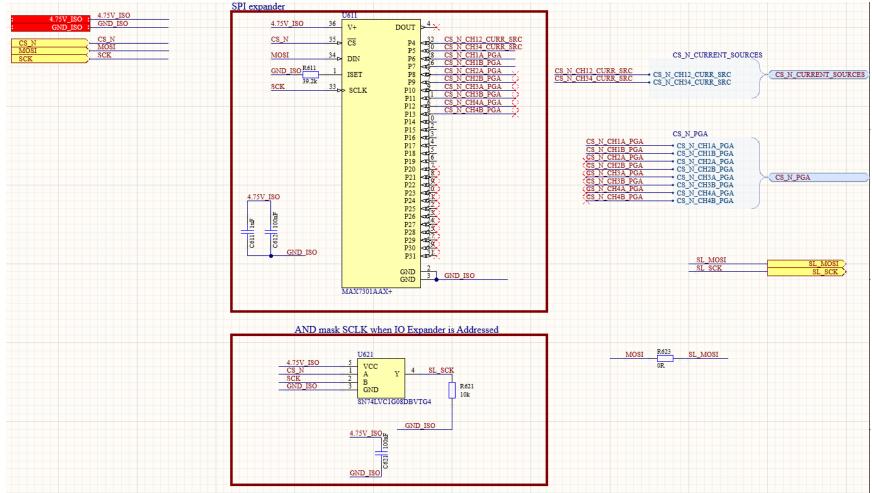
• SPI Expander Block





# The sub-module design details

• SPI Expander Block

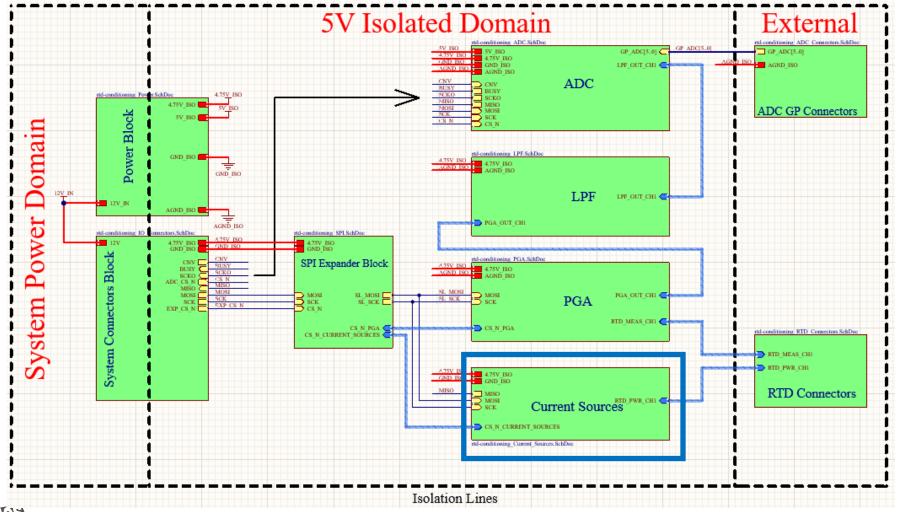






# The sub-module design details

Current Sources Block

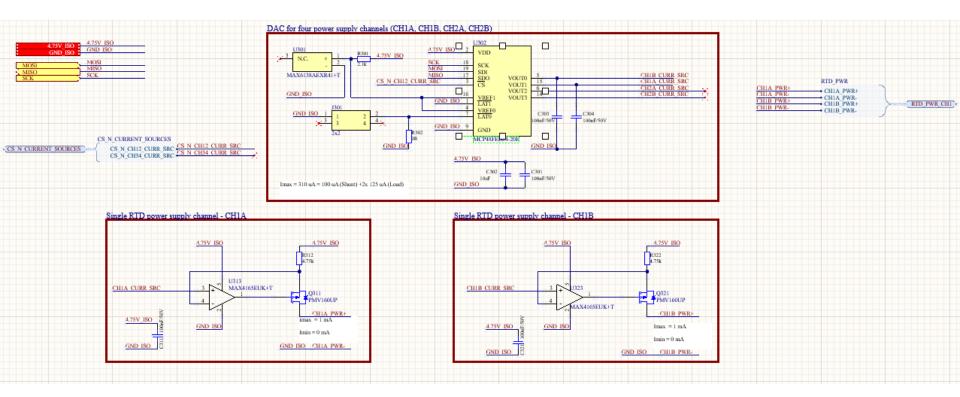






#### The sub-module design details

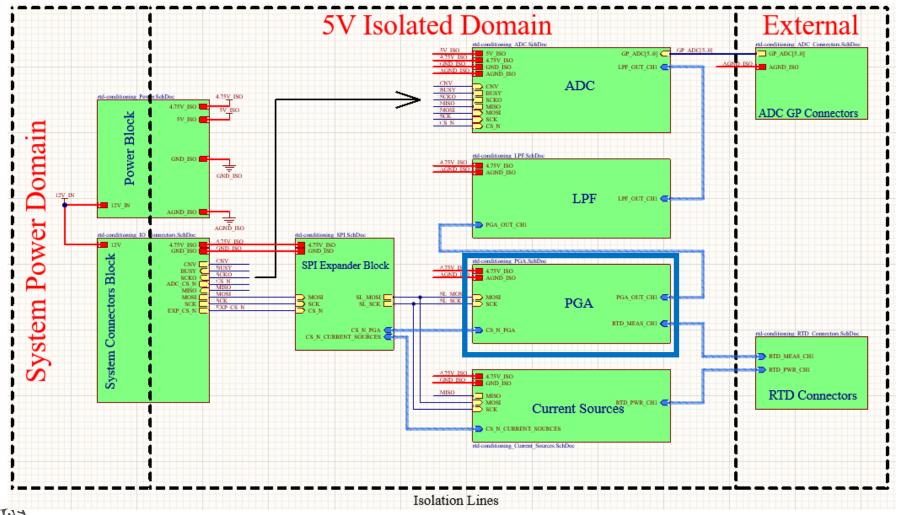
Current Sources Block







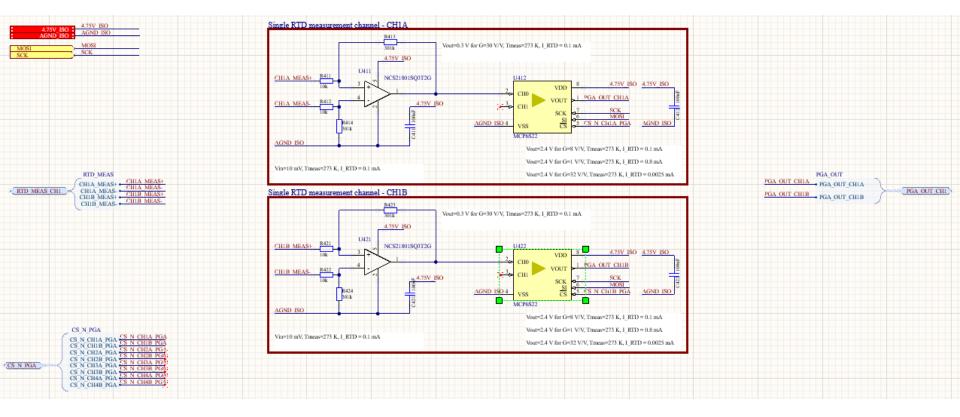
PGA Block







• PGA Block



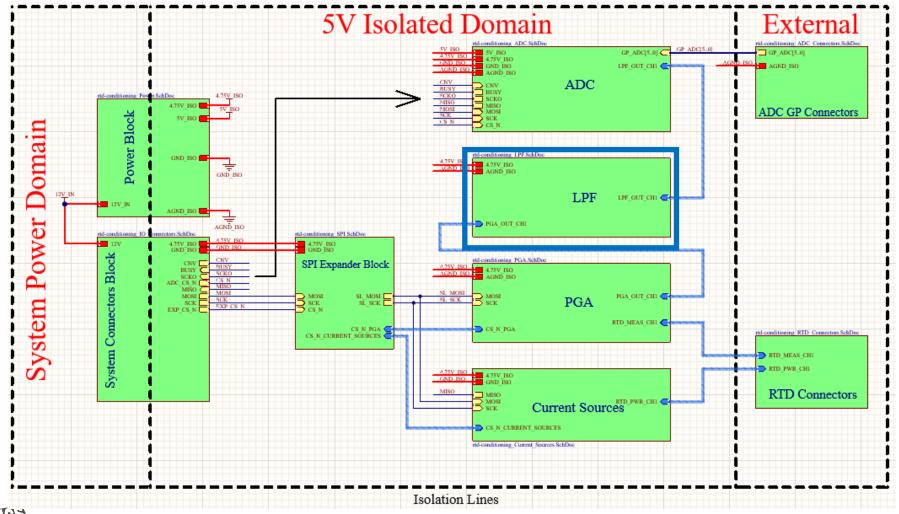


(B)



#### The sub-module design details

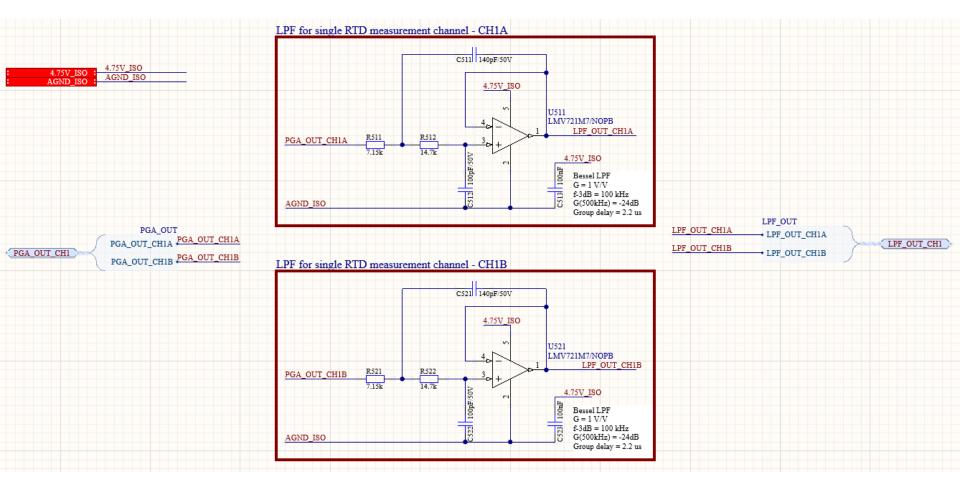
• LPF Block







• LPF Block

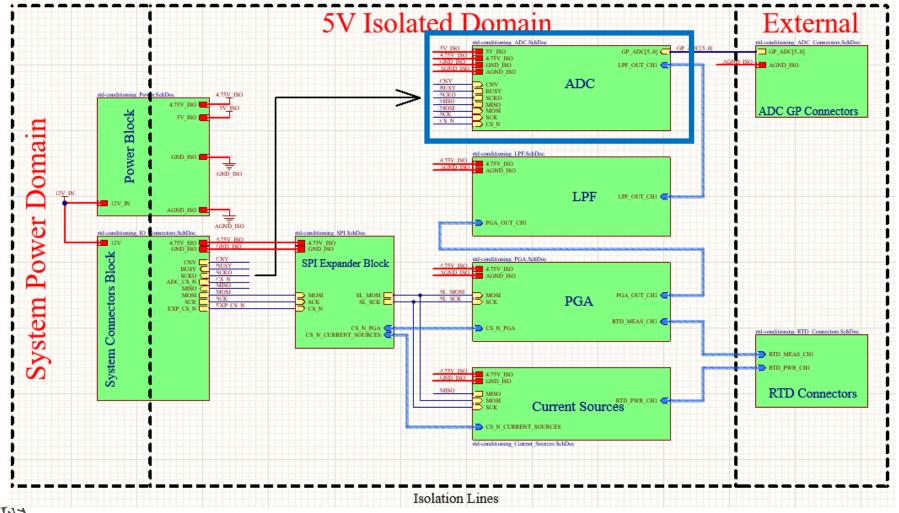






#### The sub-module design details

ADC Block

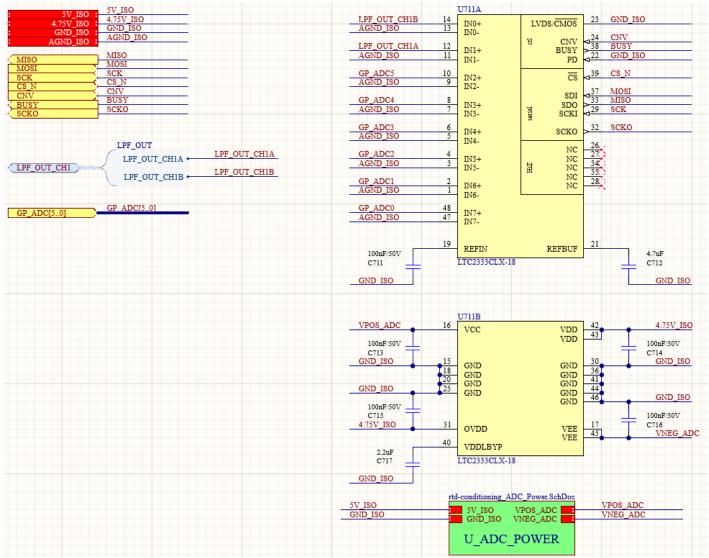






#### The sub-module design details

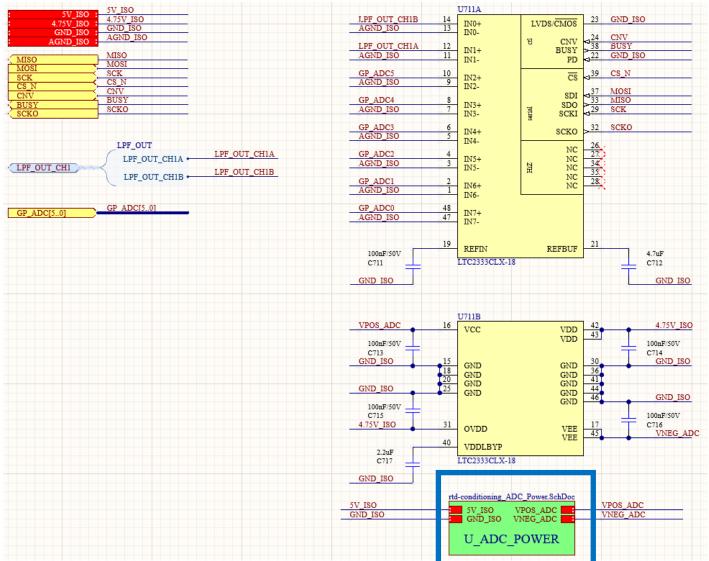
• ADC Block







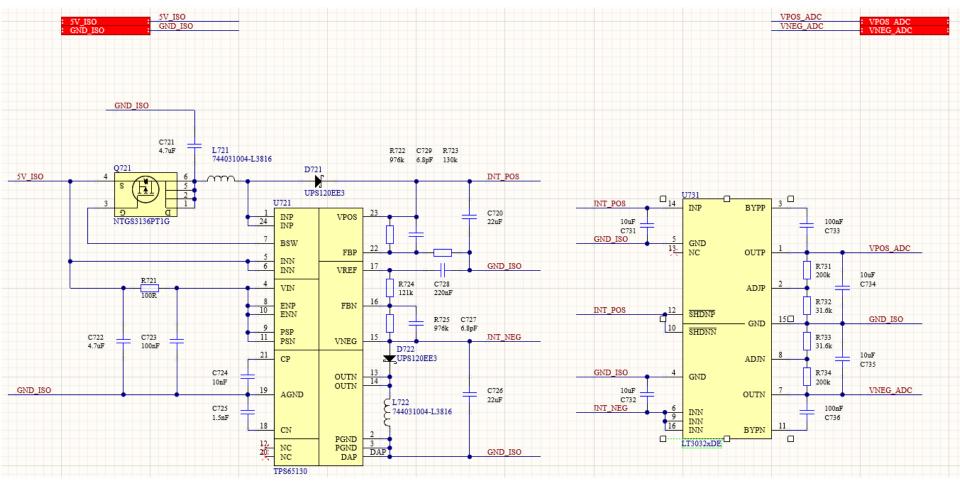
• ADC Block





# The sub-module design details

• ADC Power Block

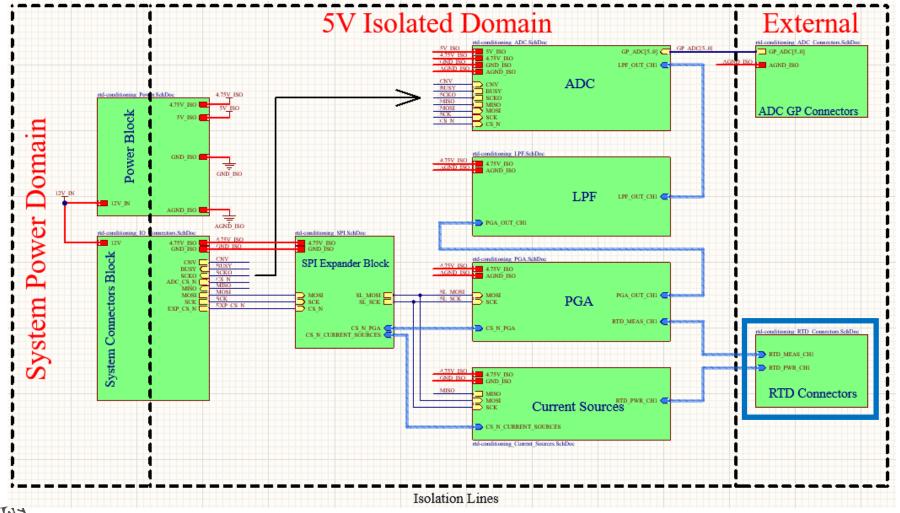






# The sub-module design details

RTD Connectors Block

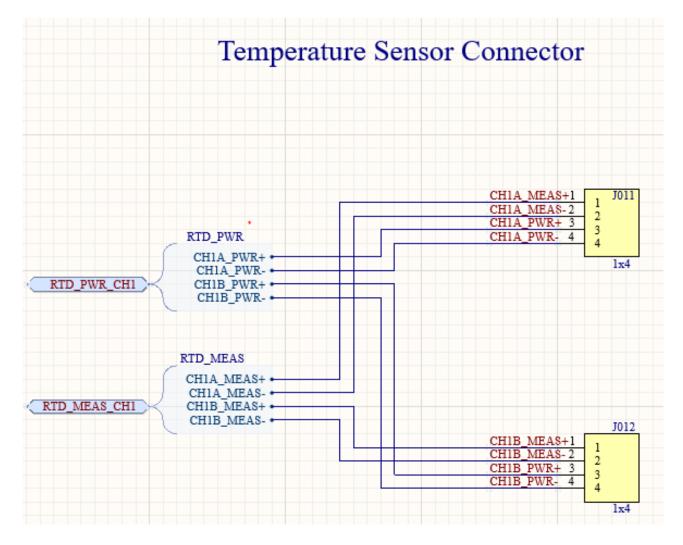






# The sub-module design details

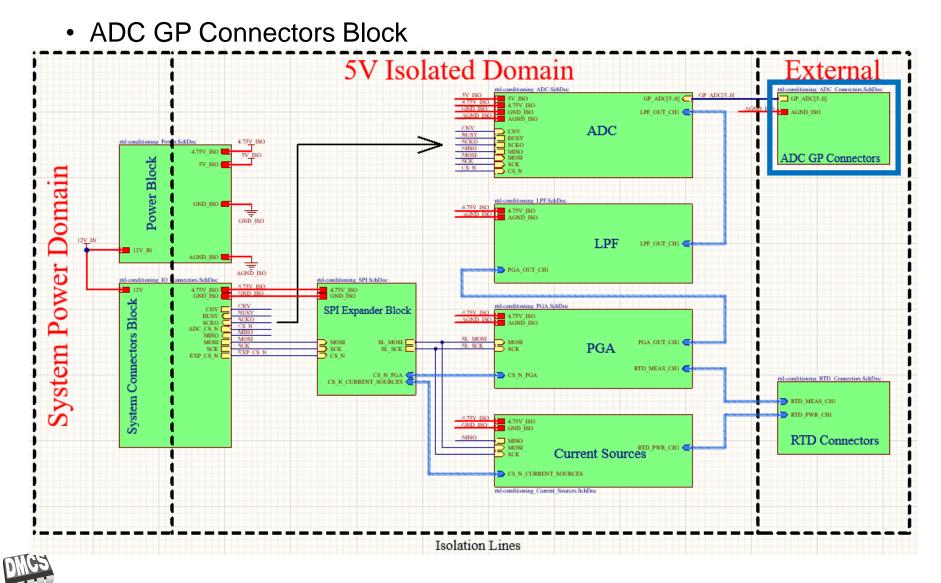
RTD Connectors Block







# The sub-module design details





# The sub-module design details

ADC GP Connectors Block

